

FORM PTO-1449 (MODIFIED) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT	ATTORNEY DOCKET NO.	SERIAL NO.
	SP01-332	
	APPLICANT Peters et al.	
	FILING DATE	GROUP:

J1046 U.S. PTO
 10/03/540
 12/21/01

REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
<i>[Signature]</i>	AA	5,395,413	3/7/95	Sempolinski	65	414	
<i>[Signature]</i>	AB	6,205,818	3/27/01	Seward II	65	33.2	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Sub-Class	Translation	
							Yes	No
<i>[Signature]</i>	AL	0 401 845B2 .	4/11/01	EPO	G02B	1/00	X	
<i>[Signature]</i>	AM	0 921 104A1 .	6/9/99	EPO	C03C	3/06	X	
<i>[Signature]</i>	AN	10-53432 .	2/24/98	Japan	C03C	3/06	X	
<i>[Signature]</i>	AO	WO 98/39496 .	9/11/98	PCT	C23C	16/40	X	
	AP							
	AQ							

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)		
<i>[Signature]</i>	AR .	G. H. Sigel, Jr., Ultraviolet Spectra of Silicate Glasses: A Review of Some Experimental Evidence, Journal of Non-Crystalline Solids, 13 (1973/74) 372-398.
<i>[Signature]</i>	AS .	Charlene M. Smith et al., Transient absorption in Excimer-Exposed Silica, Applied Optics, Vol. 39, No. 31, 1 November 2000, pp. 5778-5784.
<i>[Signature]</i>	AT .	K. Saito et al., Effects of Aluminum Impurity On The Structural Relaxation In Silica Glass, , Journal of Non-Crystalline Solids 270 (2000) 60-65.
	AU	
	AV	
	AW	

EXAMINER: *[Signature]* DATE CONSIDERED: *March 15, 2003*
 EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.